

Search Notes

Application/Control No.

10/676,315

Examiner

Sharon E. Payne

Applicant(s)/Patent under
Reexamination

HAYASHI ET AL.

Art Unit

2875

SEARCHED

Class	Subclass	Date	Examiner
362	299	9/8/2005	SEP
	609		
	610		
	614		
	616		
	619		
	623		
	628	9/9/2005	
	222		
	223		
	224		
	225		
	235		
	260	9/10/2005	

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Spoke to Y. Quach Lee (cl. 362)--said it was OK to use motivation from English abstracts of foreign refs.	9/13/2005	SEP
Spoke to Sandra O'shea--OK to use reference not in rejection to show equivalence.	9/13/2005	SEP

Search Notes (continued)

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SEARCHED

Class	Subclass	Date	Examiner
362	297	9/10/2005	SEP
	310		
	329		
	346		
	318		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR